

<b>Notice of References Cited</b>		Application/Control No. 09/802,744	Applicant(s)/Patent Under Reexamination WEE ET AL.	
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**U.S. PATENT DOCUMENTS**

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	B	US-5126961	06-1992	Garverick et al.	708/316
	C	US-5134578	07-1992	Garverick et al.	708/316
	D	US-6317765	11-2001	Page et al.	708/313
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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